

C3M0045065J1

Silicon Carbide Power MOSFET C3M™ MOSFET Technology N-Channel Enhancement Mode

Features

- 3rd generation SiC MOSFET technology
- · Optimized package with separate driver source pin
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q,,)
- Halogen free, RoHS compliant

Benefits

- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- · Increase system switching frequency

Applications

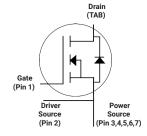
- Datacenter and Telecom Power Supplies
- EV Battery Chargers
- High voltage DC/DC converters
- Energy Storage Systems
- Solar Inverters

Package









Part Number	Part Number Package	
C3M0045065J1	TO-263-7L XL	C3M0045065J1

Maximum Ratings (T_c=25°C, unless otherwise specified)

Symbol	Parameter	Value	Unit	Note
V_{DSmax}	Drain - Source Voltage	650	٧	
V_{GSmax}	Gate - Source voltage	-8/+19	٧	Note 1
	Continuous Drain Current, V _{GS} = 15 V, T _C = 25°C			F: 40
l _D	Continuous Drain Current, V _{GS} = 15 V, T _C = 100°C	31	A	Fig. 19
I _{D(pulse)}	Pulsed Drain Current, Pulse width t _P limited by T _{jmax}	132	А	
P _D	Power Dissipation, $T_c = 25^{\circ}C$, $T_J = 150^{\circ}C$		W	Fig. 20
T _J , T _{stg}	Operating Junction and Storage Temperature		°C	
T _L	Solder Temperature, 1.6mm (0.063") from case for 10s	260	°C	

Note (1): Recommended turn off / turn on gate voltage $V_{\rm GS}$ - 4V...0V / +15V



Electrical Characteristics (T_c = 25°C unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note
V _{(BR)DSS}	Drain-Source Breakdown Voltage	650			V	V _{GS} = 0 V, I _D = 100 μA	
V Coto Throphold Voltage	1.8	2.6	3.6	V	V _{DS} = V _{GS} , I _D = 4.84 mA	Fig. 11	
$V_{GS(th)}$	Gate Threshold Voltage		2.3		V	V _{DS} = V _{GS} , I _D = 4.84 mA, T _J = 150°C	Fig. 11
I _{DSS}	Zero Gate Voltage Drain Current		1	50	μΑ	V _{DS} = 650 V, V _{GS} = 0 V	
I _{GSS}	Gate-Source Leakage Current		10	250	nA	V _{GS} = 15 V, V _{DS} = 0 V	
Ь	Drain Course On Ctota Basistanas		45	60	mΩ	V _{GS} = 15 V, I _D = 17.6 A	Fig. 4, 5,6
R _{DS(on)}	Drain-Source On-State Resistance		54		11112	V _{GS} = 15 V, I _D = 17.6 A, T _J = 150°C	
G fs	Transconductance		12		S	V _{DS} = 20 V, I _{DS} = 17.6 A	Fig. 7
yıs	Transconductance		11		Ŭ	V _{DS} = 20 V, I _{DS} = 17.6 A, T _J = 150°C	1 ig. /
C _{iss}	Input Capacitance		1621		ļ	$V_{GS} = 0 \text{ V, } V_{DS} = 0 \text{V to } 400 \text{ V}$	Fig. 17, 18
Coss	Output Capacitance		101		[F = 1 Mhz	
Crss	Reverse Transfer Capacitance		8		pF	Vac = 25 mV	
$C_{\text{o(er)}}$	Effective Output Capacitance (Energy Related)		126			V 0VV 0V+ 400V	Note: 2
C _{o(tr)}	Effective Output Capacitance (Time Related)		178			$V_{GS} = 0 \text{ V}, V_{DS} = 0 \text{V to } 400 \text{ V}$	
E _{oss}	Coss Stored Energy		10		μJ	V _{DS} = 400 V, F = 1 Mhz	Fig. 16
Eon	Turn-On Switching Energy (Body Diode)		36			$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_D = 17.6 \text{ A}, R_{G(ext)} = 2.5 \Omega, L = 99 \mu H, T_J = 25^{\circ} C$	9. = 0
E _{OFF}	Turn Off Switching Energy (Body Diode)		7		μJ	FWD = Internal Body Diode of MOSFET	
t _{d(on)}	Turn-On Delay Time		8				Fig. 26
t _r	Rise Time		10]	$V_{DD} = 400 \text{ V, } V_{GS} = -4 \text{ V/15 V}$ $I_D = 17.6 \text{ A, } R_{G(ext)} = 2.5 \Omega, L= 99 \mu H$ Timing relative to V_{DS}	
t _{d(off)}	Turn-Off Delay Time		19		ns	Timing relative to V _{DS}	
t _f	Fall Time		6]		
R _{G(int)}	Internal Gate Resistance		3		Ω	f = 1 MHz, V _{AC} = 25 mV	
Q_{gs}	Gate to Source Charge		21			V 400 V V 4 V /4 F V	Fig. 12
Q_{gd}	Gate to Drain Charge		16		nC	$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$ $I_{D} = 17.6 \text{ A}$	
Q _g	Total Gate Charge		61	7		Per IEC60747-8-4 pg 21	

Note (2): $C_{O(er)}$, a lumped capacitance that gives same stored energy as Coss while Vds is rising from 0 to 400V $C_{O(er)}$, a lumped capacitance that gives same charging time as Coss while Vds is rising from 0 to 400V



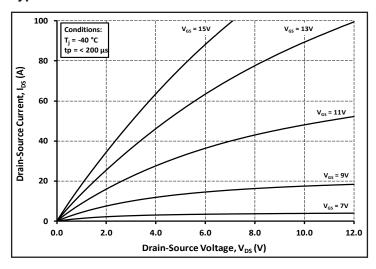
Reverse Diode Characteristics (T_c = 25°C unless otherwise specified)

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
V	Diode Forward Voltage	4.8		V	$V_{GS} = -4 \text{ V, } I_{SD} = 8.8 \text{ A, } T_{J} = 25 \text{ °C}$ $V_{GS} = -4 \text{ V, } I_{SD} = 8.8 \text{ A, } T_{J} = 150 \text{ °C}$	
V_{SD}		4.2		V		
Is	Continuous Diode Forward Current		26	Α	V _{GS} = -4 V, T _C = 25°C	
I _{S, pulse}	Diode pulse Current		132	Α	V_{GS} = -4 V, pulse width t_P limited by T_{jmax}	
t _{rr}	Reverse Recover time	10		ns		
Q _{rr}	Reverse Recovery Charge	206		nC	$V_{gs} = -4 \text{ V, } I_{SD} = 17.6 \text{ A, } V_{R} = 400 \text{ V}$ dif/dt = 5420 A/ μ s, $T_{J} = 25 \text{ °C}$	
I _{rrm}	Peak Reverse Recovery Current	36		Α		
t _{rr}	Reverse Recover time	13		ns	V _{GS} = -4 V, I _{SD} = 17.6 A, V _R = 400 V dif/dt = 1915 A/μs, T _J = 25 °C	
Q _{rr}	Reverse Recovery Charge	103		nC		
I _{rrm}	Peak Reverse Recovery Current	14		А		

Thermal Characteristics

Symbol	Parameter	Тур.	Unit	Test Conditions	Note
R _θ JC	Thermal Resistance from Junction to Case	0.85	20.044		F: 04
$R_{\theta JA}$	Thermal Resistance From Junction to Ambient	40	°C/W		Fig. 21





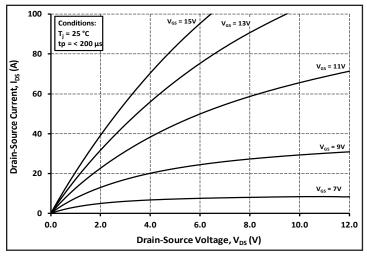
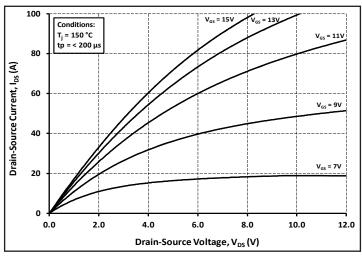


Figure 1. Output Characteristics T_J = -40 °C





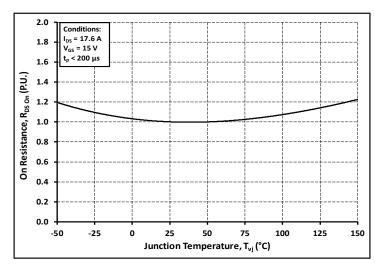
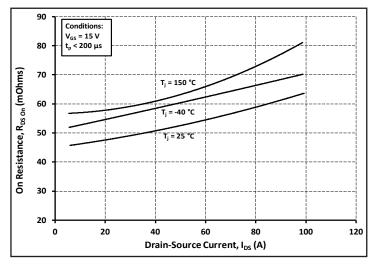


Figure 3. Output Characteristics T_J = 150 °C





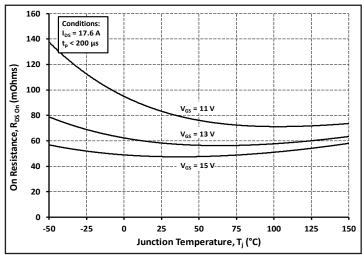
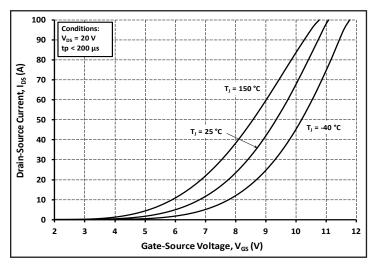


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

Figure 6. On-Resistance vs. Temperature For Various Gate Voltage





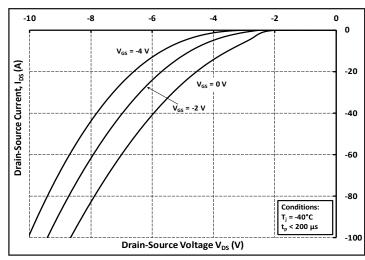
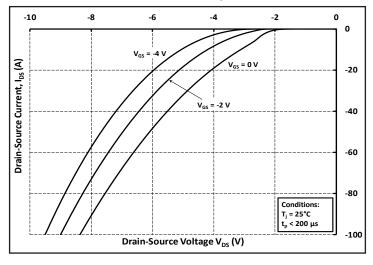


Figure 7. Transfer Characteristic for Various Junction Temperatures





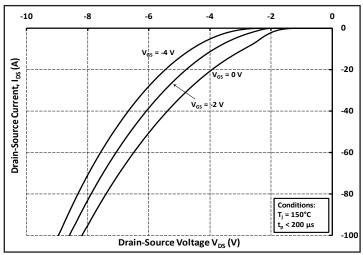
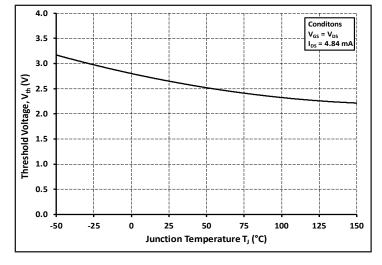


Figure 9. Body Diode Characteristic at 25 °C

Figure 10. Body Diode Characteristic at 150 °C



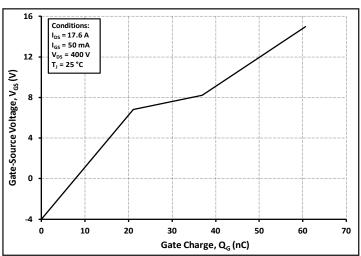


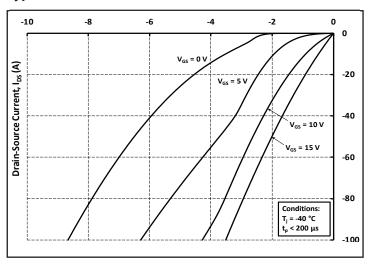
Figure 11. Threshold Voltage vs. Temperature

Figure 12. Gate Charge Characteristics



I_{DS} (A)

Drain-Source Current,



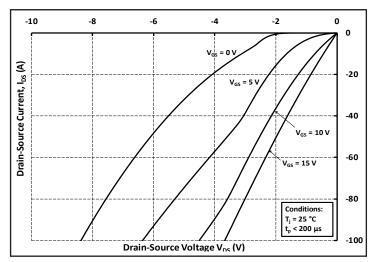
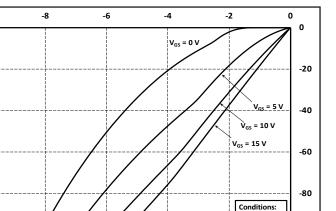


Figure 13. 3rd Quadrant Characteristic at -40 °C



T_j = 150 °C t_n < 200 μs

-100

Figure 14. 3rd Quadrant Characteristic at 25 °C

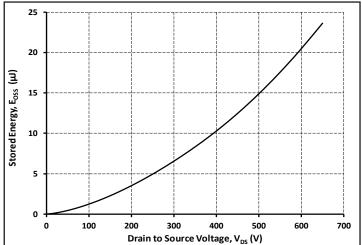


Figure 15. 3rd Quadrant Characteristic at 150 °C

Drain-Source Voltage V_{DS} (V)

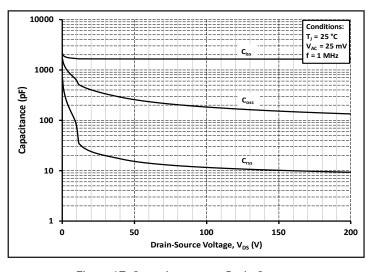


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

Figure 16. Output Capacitor Stored Energy

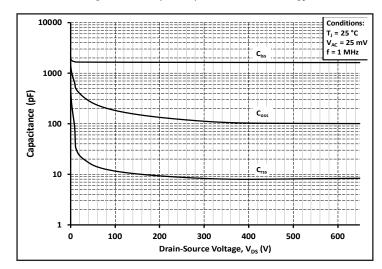
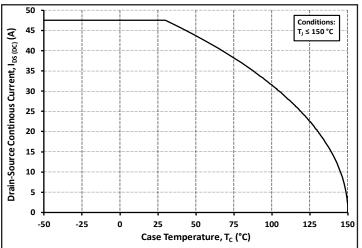


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 600V)





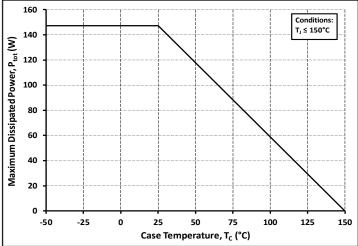
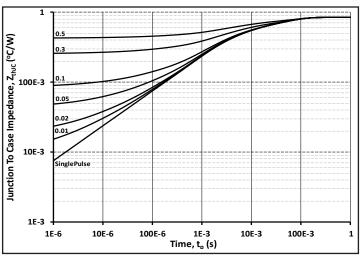


Figure 19. Continuous Drain Current Derating vs.

Case Temperature

Figure 20. Maximum Power Dissipation Derating vs.

Case Temperature



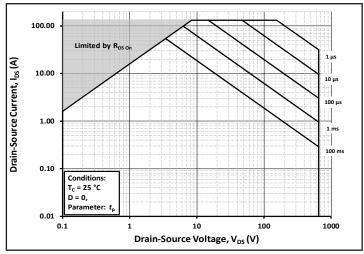
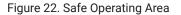
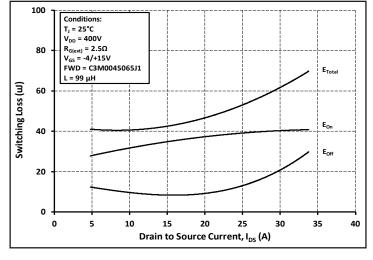


Figure 21. Transient Thermal Impedance (Junction - Case)





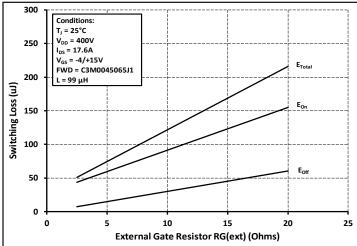
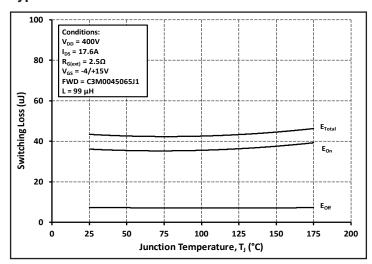


Figure 23. Clamped Inductive Switching Energy vs. Drain Current $(V_{DD} = 400V)$

Figure 24. Clamped Inductive Switching Energy vs. $R_{G(ext)}$





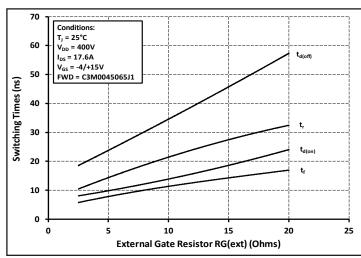
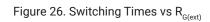


Figure 25. Clamped Inductive Switching Energy vs.
Temperature



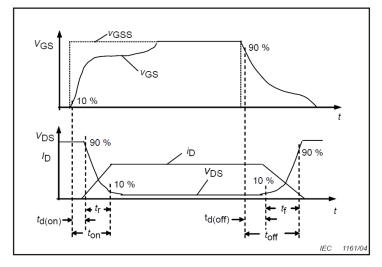


Figure 27. Switching Times Definition



Test Circuit Schematic

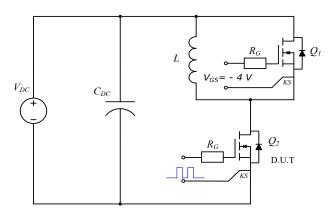
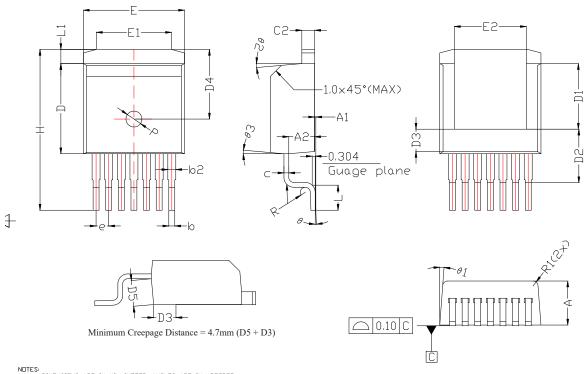


Figure 28. Clamped Inductive Switching Waveform Test Circuit

Note (3): Turn-off and Turn-on switching energy and timing values measured using SiC MOSFET Body Diode as shown above.

Package Dimensions

TO-263-7L XL



DIM	MIN	MAX	TYP				
D	9.025	9.125	9.075				
E	10.13	10.23	10.18				
Α	4.30	4.57	4.435				
Н	15.043	17.313	16.178				
D1	6.50	6.70	6.60				
E1	6.50	8.60	7.55				
D2	5	.39 RE	F.				
E2	6.778	7.665	7.223				
DЗ	2.148		2.248				
D4	7	.00 RE	F.				
D5	2.555		2.605				
A1	0	0.25	0.125				
A2	2.	595 R	EF.				
е	1.	27 TY	Ρ.				
L	2.324	2.70	2.512				
b	0.50	0.70	0.60				
L1	0.968	1.868	1.418				
b2	0.60	1.00	0.80				
C5	1.17	1.37	1.27				
\subset	0.281	0.481	0.381				
R	0.506 REF.						
R1	0.50 REF.						
Ρ	Ø1.60 REF.						
θ	0°	8°	4°				
θ1	4.5°	5.5°	5°				
θ2	4°	6°	5°				
θ3	4°	6°	5°				

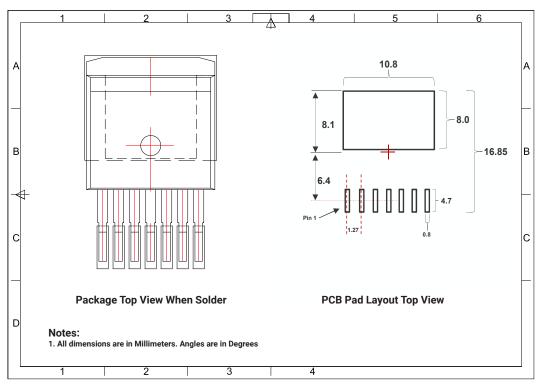
NOTES:

1. ALL DIMENSIONS ARE IN MILLIMETER. ANGLES ARE IN DEGREE.
2. DIMENSION 'D' DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSIONS. INTERLEAD FLASH SHALL
NOT EXCEED 0.50 MM PER SIDE. DIMENSION 'E' DOES NOT INCLUDE MOLD FLASH, GATE BURRS,THE
GATE BURRS SHALL NOT EXCEED 0.30MM .

3. THE PACKAGE TOP MAY BE SMALLER THAN THE PACKGE BOTOM. DIMENSIONS D AND E ARE
DETERMINED AT THE OUTERMOST EXTERMES OF THE PLASTIC BODY EXCLUSIVE OF MOLD FLASH, TIE
BAR BURRS, GATE BURRS AND INTERLEAD FLASH,BUT INCLUDING ANY MISMATCH BETWEEN THE TOP
AND BOTTOM OF THE PLASTIC BODY.

4. '62' DIMENSION DON'T INCLUDE DAMBAR PROTRUSION.

5. THE VOID SHOULD BE CONTROL WITHIN 0.25MM.





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EFC2J004NUZTDG ECH8691-TL-W FCAB21350L1 P85W28HP2F-7071 DMN1053UCP4-7 NTE2384 NTE2969 NTE6400A
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